

Notice of References Cited	Application/Control No. 10/089,409	Applicant(s)/Patent Under Reexamination AIKOH ET AL.	
	Examiner TAN X. DINH	Art Unit 2653	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,608,718 A	03-1997	Schiewe, Hilmar	369/275.4
B	US-5,608,717 A	03-1997	Ito et al.	369/275.3
C	US-5,527,479 A	06-1996	Nagataki et al.	508/205
D	US-5,663,211	09-1997	Kominami et al.	522/8
E	US-5,748,607	05-1998	Ohira et al.	369/275.4
F	US-5,540,988	07-1996	Tachibana et al.	428/323
G	US-6,333,900	12-2001	Maro et al.	369/13.17
H	US-6,044,043	03-2000	Aoki et al.	369/13.2
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	3-157,837A	07-1991	JAPAN	MATSUSHITA ELECTRIC CO	369/13.38
O	3-125,352	05-1991	JAPAN	YAMANAKA, FUMIE	369/13.38
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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